Docket No.: GR 98 P 1379 D

28/4

Thereby certify that this correspondence is being deposited with the United States Postal Service with sufficient postage as First Class Mail in an envelope addressed to the Assistant Commissioner for Patents, Washington, D.C. 20231, on the date indicated below.

Date: 1/ 5/0/

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant

Lars-Peter Heineck et al.

Applic. No.

09/885,553

Filed

June 20, 2001

Title

MOS Transistor in a Single-Transistor Memory Cell Having a

Locally Thickened Gate Oxide

Art Unit

2814

## **INFORMATION DISCLOSURE STATEMENT**

Hon. Commissioner of Patents and Trademarks, Washington, D.C. 20231

Sir:

In accordance with 37 C.F.R. 1.98 copies of the following patents and/or publications are submitted herewith:

Japanese Patent Abstract JP 06 283 686 (Ota), dated October 7, 1994;

Japanese Patent Abstract JP 9 186 250 A2 (Ryu), dated July 15, 1997;

Kurimoto, K. et al.: A T-gate Overlapped LDD Device with High Circuit Performance and High Reliability", International Electron Devices Meeting 1991, Washington, D.C., December 8-11, 1991, pp. 541-544, XP-000342187.

If no translation of pertinent portions of any foreign language patents or publications mentioned above is included with the aforementioned copies of those applications,

patents and/or publications, it is because no existing translation is readily available to the applicant.

Respectfully submitted,

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For Applicants

Date: November 5, 2001

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